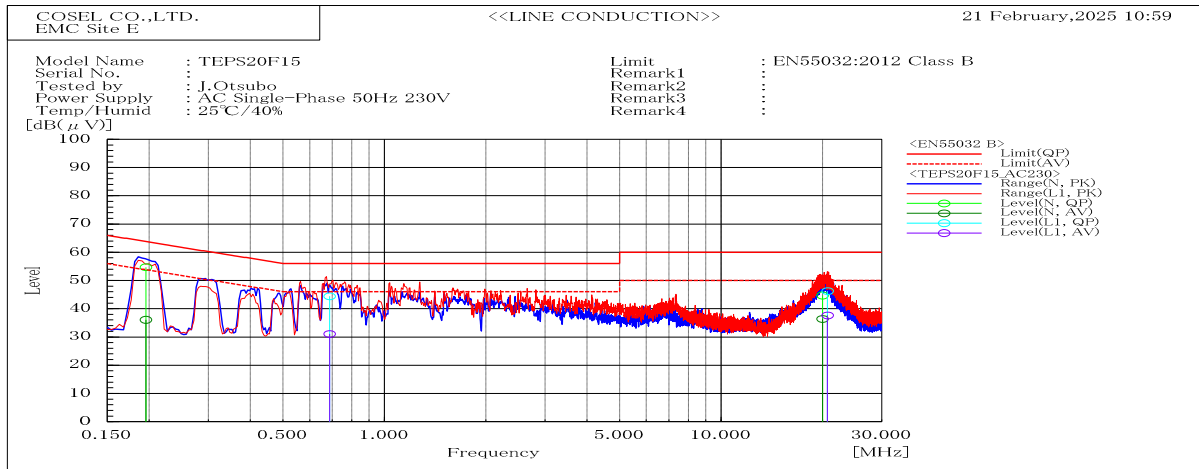
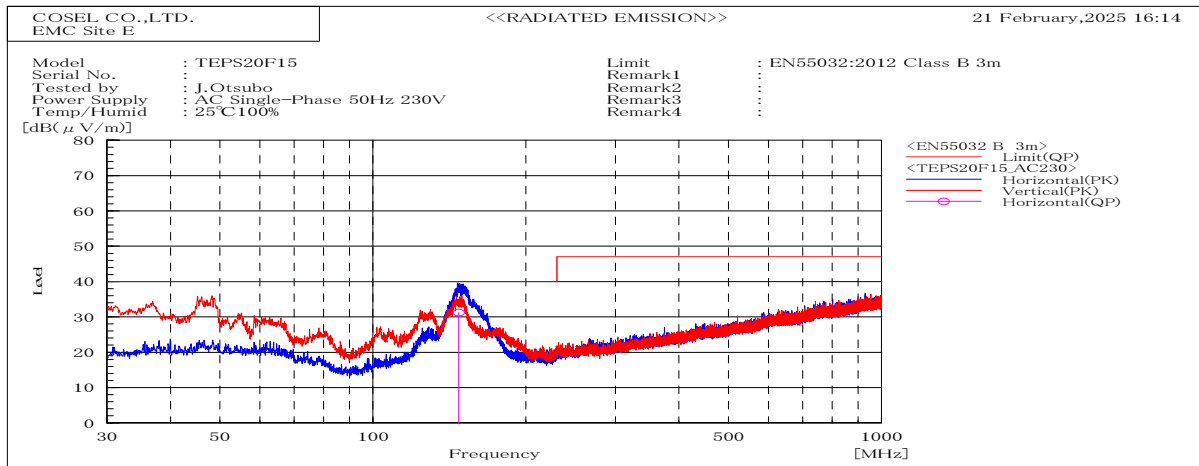


DATA SHEET		Date	24-Mar-25
Model	TEPS20F15	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



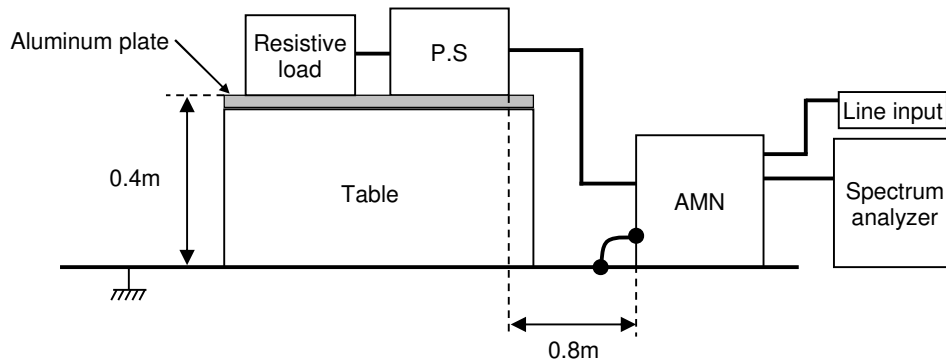
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.687	L1	44.4	31.1	56	46	11.6	14.9	Pass	
20.702	L1	46.3	37.7	60	50	13.7	12.3	Pass	
0.196	N	54.7	36.1	63.8	53.8	9.1	17.7	Pass	
20.016	N	44.7	36.4	60	50	15.3	13.6	Pass	



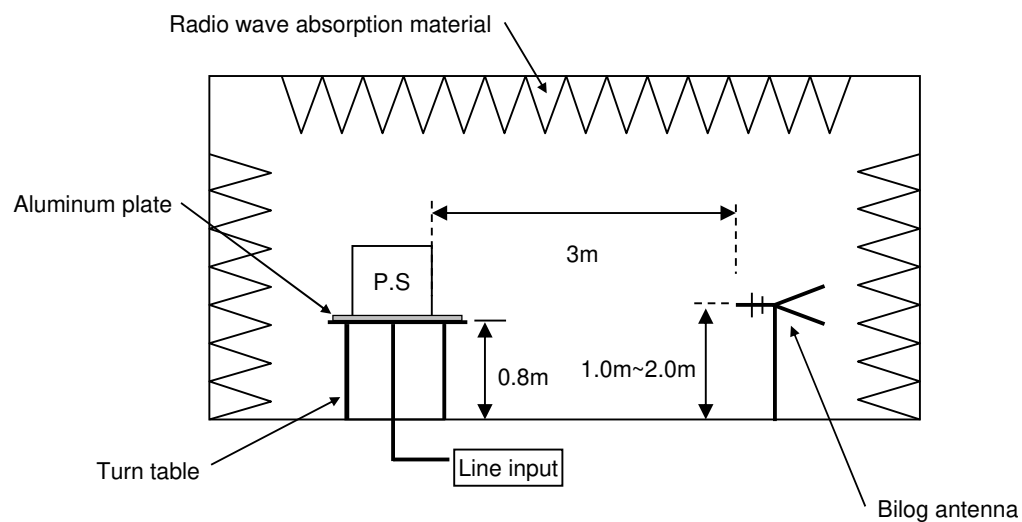
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP		cm	deg	
147.498	H	Stable	31.2	40	8.8	Pass	199.6	238.1	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

### 1. Line conduction



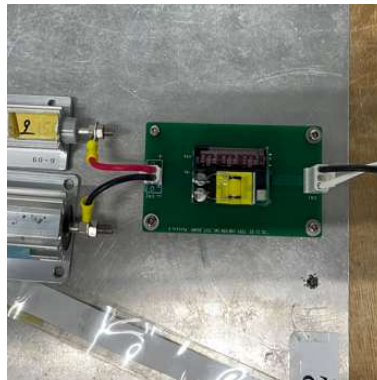
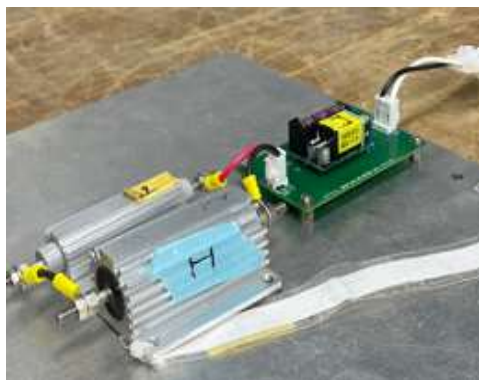
### 2. Radiated emission



## Conditions

Test : EMI  
Model Name : TEPS20F15

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

